


<b>Search Notes</b> 	<b>Application/Control No.</b> 10576091	<b>Applicant(s)/Patent Under Reexamination</b> GEIER ET AL.
	<b>Examiner</b> LEE D WILSON	<b>Art Unit</b> 3727

SEARCHED			
Class	Subclass	Date	Examiner
269	170, 254CS, 6, 3	9/22/2009	LW
	UPDATED	9/22/2009	LW

SEARCH NOTES		
Search Notes	Date	Examiner
UPDATED EAST SEARCH	9/22/2009	LW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	UPDATED	9/22/2009	LW

--	--